## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination

10/562,769 HEYWOOD ET AL.

Examiner Art Unit

1643

David J. Blanchard

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
SEQ ID	Nos:1-14	2/8/2008	DB	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST, STN - medline embase, esbiobase, scisearch, lifesci, biosis, biotechno, dissabs, inventor search (see search notes)	2/11/2008	DB		
STIC search SEQ ID Nos;1-10 (results in SCORE)	2/5/2008	DB		
STIC search SEQ ID Nos:11-14 (results in SCORE)	2/8/2008	DB		
Invnetor search in PALM	2/11/2008	DB		